



ALPHA & OMEGA
SEMICONDUCTOR

AONR34332C
30V N-Channel MOSFET

General Description

- Trench Power MOSFET technology
- Low $R_{DS(ON)}$ at 2.5V V_{GS}
- Low Gate Charge
- RoHS and Halogen-Free Compliant

Applications

- Load switch, battery switch in portable devices

Product Summary

| | |
|----------------------------------|---------|
| V_{DS} | 30V |
| I_D (at $V_{GS}=10V$) | 100A |
| $R_{DS(ON)}$ (at $V_{GS}=10V$) | < 1.6mΩ |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$) | < 1.9mΩ |
| $R_{DS(ON)}$ (at $V_{GS}=2.5V$) | < 2.9mΩ |

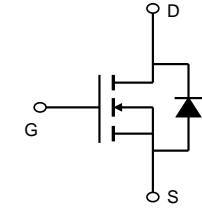
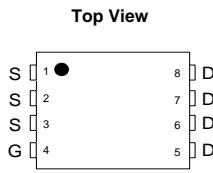
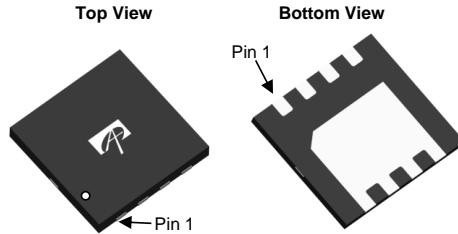
Typical ESD Level

HBM Class 2

100% UIS Tested
100% R_g Tested



DFN 3.3x3.3 EP



| Orderable Part Number | Package Type | Form | Minimum Order Quantity |
|-----------------------|---------------|-------------|------------------------|
| AONR34332C | DFN3.3x3.3 EP | Tape & Reel | 5000 |

Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|---|----------------|------------|-------|
| Drain-Source Voltage | V_{DS} | 30 | V |
| Gate-Source Voltage | V_{GS} | ± 12 | V |
| Continuous Drain Current ^G | I_D | 100 | A |
| $T_C=100^\circ C$ | | 95 | |
| Pulsed Drain Current ^C | I_{DM} | 400 | |
| Continuous Drain Current | I_{DSM} | 40 | A |
| $T_A=70^\circ C$ | | 32 | |
| Avalanche Current ^C | I_{AS} | 70 | A |
| Avalanche energy ^{L=0.05mH} ^C | E_{AS} | 123 | mJ |
| Power Dissipation ^B | P_D | 56 | W |
| $T_C=100^\circ C$ | | 22 | |
| Power Dissipation ^A | P_{DSM} | 4.1 | W |
| $T_A=70^\circ C$ | | 2.6 | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | °C |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|---|-----------------|-----------------|-----|-------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 25 | 30 | °C/W |
| $t \leq 10s$ | | 50 | 60 | °C/W |
| Maximum Junction-to-Ambient ^{AD} | Steady-State | | | |
| Maximum Junction-to-Case | Steady-State | $R_{\theta JC}$ | 1.8 | 2.2 |

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|--|-----|------|-----|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$ | 30 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=30\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | 1 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS}=\pm 12\text{V}$ | | | 5 | nA |
| $V_{\text{GS(th)}}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$ | 0.5 | 0.85 | 1.2 | V |
| $R_{\text{DS(ON)}}$ | Static Drain-Source On-Resistance | $V_{GS}=10\text{V}, I_D=20\text{A}$ $T_J=125^\circ\text{C}$ | | 1.3 | 1.6 | $\text{m}\Omega$ |
| | | $V_{GS}=4.5\text{V}, I_D=20\text{A}$ | | 1.9 | 2.4 | $\text{m}\Omega$ |
| | | $V_{GS}=2.5\text{V}, I_D=20\text{A}$ | | 2 | 2.9 | $\text{m}\Omega$ |
| g_{FS} | Forward Transconductance | $V_{DS}=5\text{V}, I_D=20\text{A}$ | | 150 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=1\text{A}, V_{GS}=0\text{V}$ | | 0.6 | 1 | V |
| I_s | Maximum Body-Diode Continuous Current | | | | 50 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$ | | 5000 | | pF |
| C_{oss} | Output Capacitance | | | 1450 | | pF |
| C_{iss} | Reverse Transfer Capacitance | | | 200 | | pF |
| R_g | Gate resistance | $f=1\text{MHz}$ | 0.3 | 0.7 | 1.5 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10\text{V})$ | Total Gate Charge | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=20\text{A}$ | | 78 | 110 | nC |
| $Q_g(4.5\text{V})$ | Total Gate Charge | | | 36 | 50 | nC |
| Q_{gs} | Gate Source Charge | | | 10 | | nC |
| Q_{gd} | Gate Drain Charge | | | 10 | | nC |
| $t_{\text{D(on)}}$ | Turn-On DelayTime | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=0.75\Omega, R_{\text{GEN}}=3\Omega$ | | 9 | | ns |
| t_r | Turn-On Rise Time | | | 8 | | ns |
| $t_{\text{D(off)}}$ | Turn-Off DelayTime | | | 85 | | ns |
| t_f | Turn-Off Fall Time | | | 18 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=20\text{A}, \text{di/dt}=500\text{A}/\mu\text{s}$ | | 21 | | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=20\text{A}, \text{di/dt}=500\text{A}/\mu\text{s}$ | | 57 | | nC |

A. The value of R_{DSM} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{ C}$. The Power dissipation P_{DSM} is based on $R_{\text{DSM}} \leq 10\text{s}$ and the maximum allowed junction temperature of 150° C . The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=150^\circ\text{ C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}=150^\circ\text{ C}$.

D. The R_{JJA} is the sum of the thermal impedance from junction to case R_{JJC} and case to ambient.

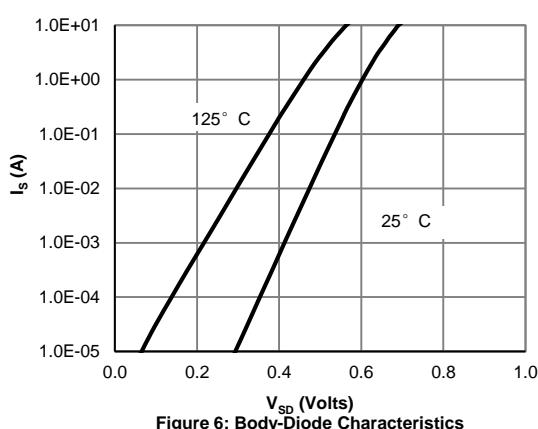
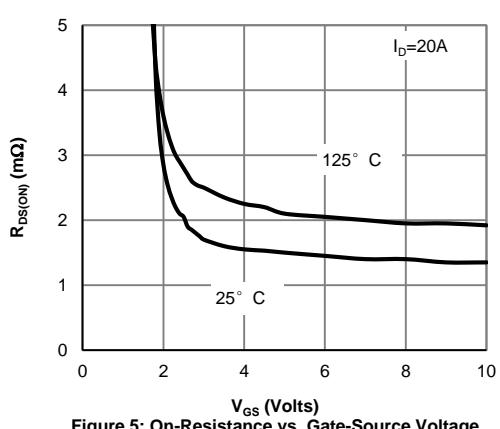
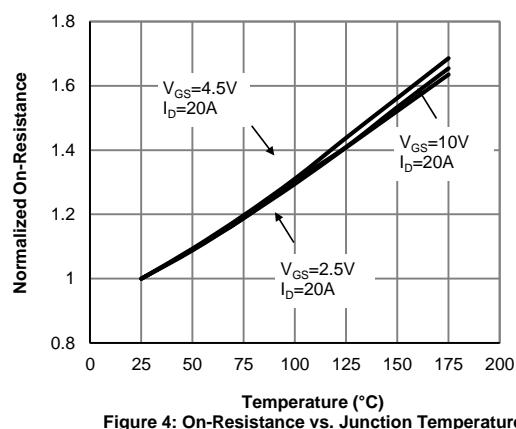
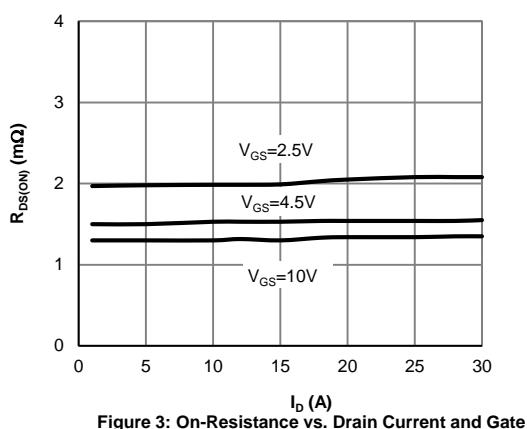
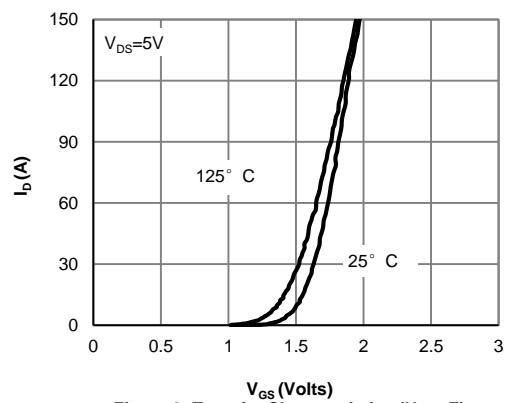
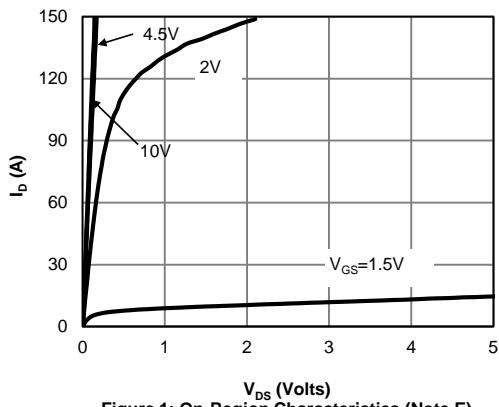
E. The static characteristics in Figures 1 to 6 are obtained using $<300\mu\text{s}$ pulses, duty cycle 0.5% max.

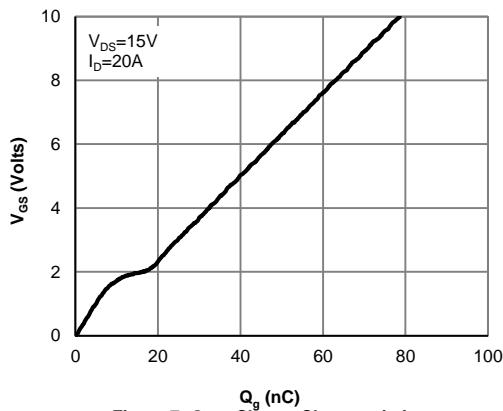
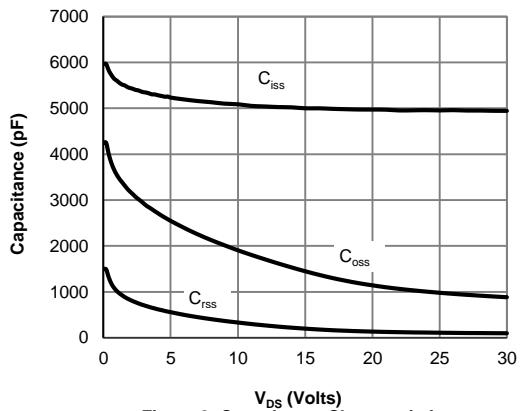
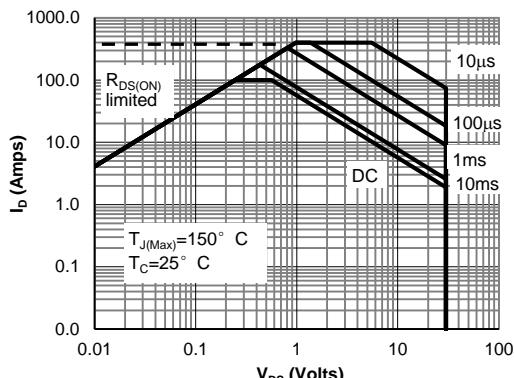
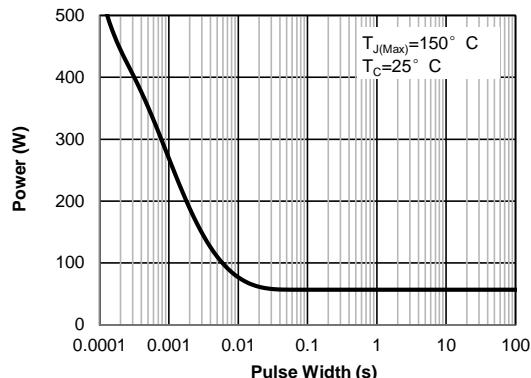
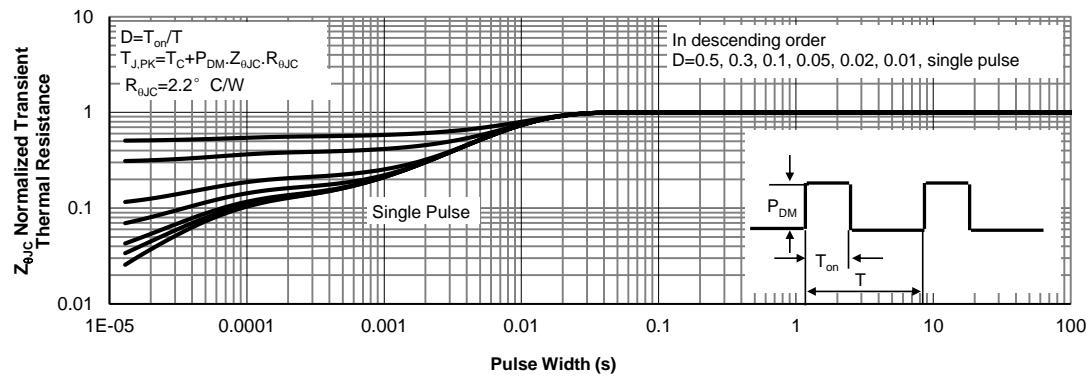
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=150^\circ\text{ C}$. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{ C}$.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


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Figure 7: Gate-Charge Characteristics

Figure 8: Capacitance Characteristics

Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

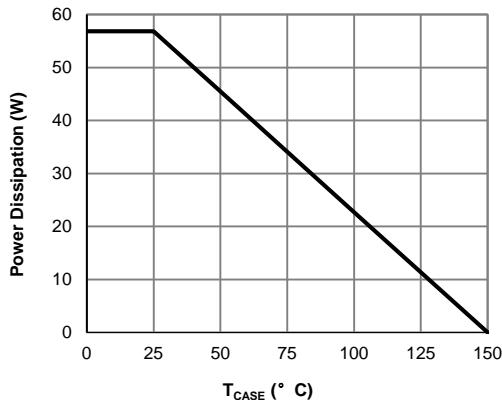
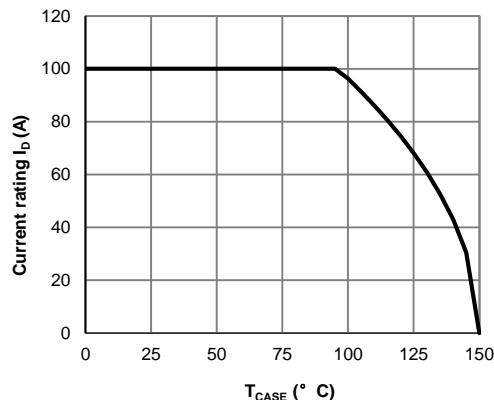
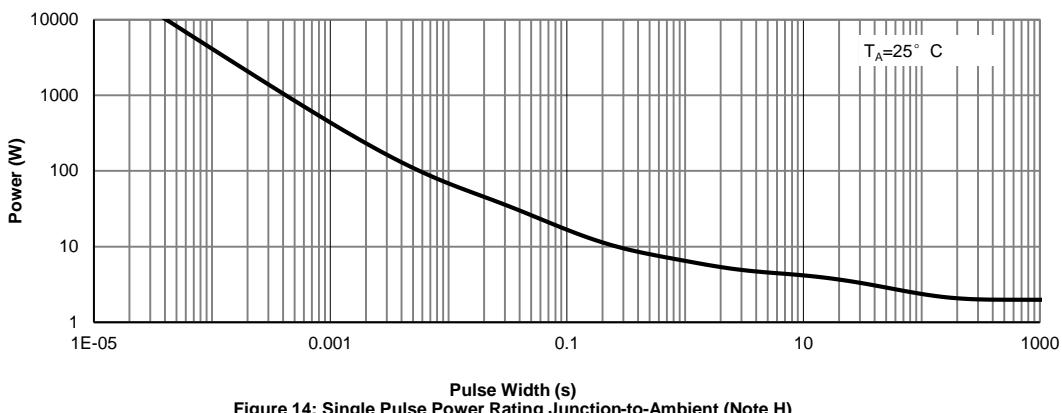
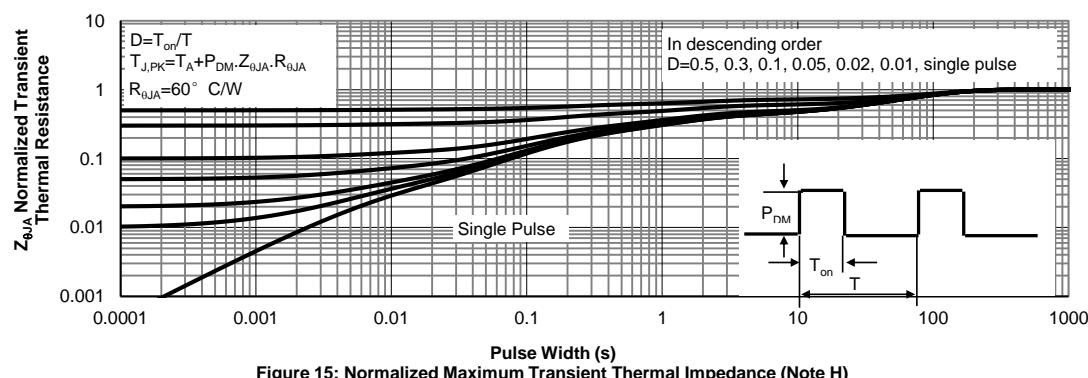
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Figure 12: Power De-rating (Note F)

Figure 13: Current De-rating (Note F)

Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

Figure A: Gate Charge Test Circuit & Waveforms

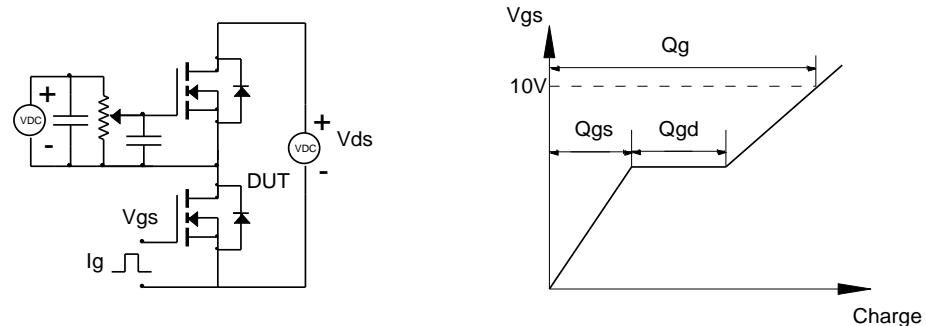


Figure B: Resistive Switching Test Circuit & Waveforms

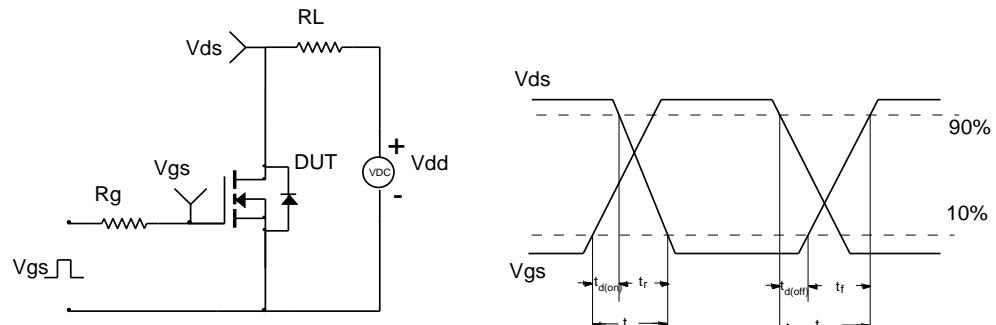


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

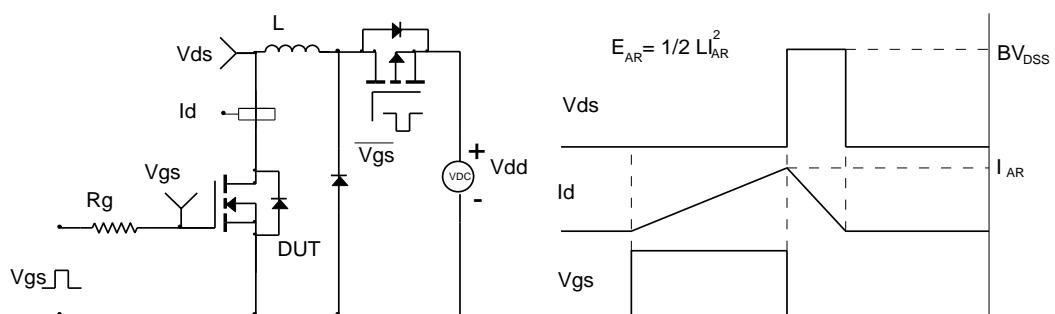


Figure D: Diode Recovery Test Circuit & Waveforms

